

EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	1	"5543339".pn.	US-PGPUB; USPAT	OR	OFF	2006/10/12 10:38
L3	13	("5402371" "5856943" "5901084" "6057575" "6130129" "6134144" "6171909" "6200856" "6261856" "6266278" "6326661" "6355524" "6365457").PN.	US-PGPUB; USPAT	OR	OFF	2006/10/12 10:55
L4	12	("20020064071" "20020197888" "20030218908" "20040004863" "6414872" "6420231" "6437360" "6438036" "6486023" "6518618" "6541324" "6541829").PN.	US-PGPUB; USPAT	OR	OFF	2006/10/12 14:08
L5	1	"6962852".pn.	US-PGPUB; USPAT	OR	OFF	2006/10/12 14:10
L6	4280	438/259.ccls. 438/260.ccls. 438/261.ccls. 438/265.ccls. 438/266.ccls. 438/294.ccls. 438/296.ccls. 438/593.ccls. 257/e21.628.ccls. 257/e21.68.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	OFF	2006/10/12 14:13
L7	542	438/266.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	OFF	2006/10/12 16:00
L8	617	6 and (((nonvolatile volatile flash) near memory) eeprom eprom rom) same (float\$6 near (gate electrode)) same ((interconnect\$6 line trace wir\$6 metal\$1i?ation) with gate))	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/10/12 16:06
L9	215	6 and (((nonvolatile volatile flash) near memory) eeprom eprom rom) same (float\$6 near (gate electrode)) same ((interconnect\$6 line trace wir\$6 metal\$1i?ation) with gate with (two second plural\$6 multiple)))	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/10/12 16:07
L10	147	6 and (((nonvolatile volatile flash) near memory) eeprom eprom rom) same (float\$6 near (gate electrode)) same ((interconnect\$6 line trace wir\$6 metal\$1i?ation) with (gate near4 (two second plural\$6 multiple))))	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/10/12 16:19

EAST Search History

L11	30	6 and (((nonvolatile volatile flash) near memory) eeprom eprom rom) same (float\$6 near (gate electrode)) same (etch\$6 with (liquid wet isotropic\$6)) same (isolation sti fox (field adj oxide) trench))	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2006/10/12 17:02
L12	33	(((nonvolatile volatile flash) near memory) eeprom eprom rom) and (float\$6 near (gate electrode)) and (etch\$6 with (liquid wet isotropic\$6)) and (isolation sti fox (field adj oxide) trench)	FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/12 17:12
L13	300	(((nonvolatile volatile flash) near memory) eeprom eprom rom) and (float\$6 near (gate electrode)) and ((interconnect\$6 line trace wir\$6 metal\$1i?ation) with (gate near4 (two second plural\$6 multiple)))	FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/12 16:14
L14	79	(((nonvolatile volatile flash) near memory) eeprom eprom rom) and (float\$6 near (gate electrode)) and ((interconnect\$6 line trace wir\$6 metal\$1i?ation) near4 (gate near2 (two second plural\$6 multiple)))	FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/10/12 17:21
L15	448	(((nonvolatile volatile flash) near memory) eeprom eprom rom) same (float\$6 near (gate electrode)) same ((interconnect\$6 line trace wir\$6 metal\$1i?ation) near4 (gate near2 (two second plural\$6 multiple)))	US-PGPUB; USPAT	OR	ON	2006/10/12 16:16
L16	335	(((nonvolatile volatile flash) near memory) eeprom eprom rom) same (float\$6 near (gate electrode)) same ((interconnect\$6 line trace wir\$6 metal\$1i?ation) near4 (gate near2 (two second plural\$6 multiple))) same ((select control) near (gate electrode))	US-PGPUB; USPAT	OR	ON	2006/10/12 16:18
L17	105	(((nonvolatile volatile flash) near memory) eeprom eprom rom) same (float\$6 near (gate electrode)) same ((interconnect\$6 line trace wir\$6 metal\$1i?ation) near4 (gate near2 (two second plural\$6 multiple))) same (select near (gate electrode))	US-PGPUB; USPAT	OR	ON	2006/10/12 17:38

EAST Search History

L18	87	((nonvolatile volatile flash) near memory) eeprom eprom rom) same (float\$6 near (gate electrode)) same (etch\$6 with (liquid wet isotropic\$6)) same (isolation sti fox (field adj oxide) trench)	US-PGPUB; USPAT	OR	ON	2006/10/12 17:59
S4	2	ep-938098-.did.	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT	OR	OFF	2006/10/02 14:46